

<b>Notice of References Cited</b>	Application/Control No. 10/575,262		Applicant(s)/Patent Under Reexamination MURAKAMI, FUMIKI	
	Examiner Haidung D. Nguyen		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,528,559 B1	03-2003	Nakacho et al.	524/116
*	B	US-2003/0114606 A1	06-2003	Taniguchi et al.	525/523
*	C	US-2005/0004292 A1	01-2005	Harashina et al.	524/430
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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